

FORM HDP-1449 (Based on Form PTO-1449) PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION (Use several sheets if necessary) Sheet 1 of 1	ATTORNEY DOCKET No.	SERIAL No.
	9319S-000289	10/001,249
	APPLICANT	
	Hideki Uehara	
	FILING DATE	GROUP
	10/31/2001	2871

U.S. PATENT DOCUMENTS						
Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.	①	5,986,739	11/16/1999	Kobayashi	—	

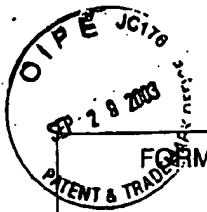
FOREIGN PATENT DOCUMENTS							
Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation *	
						Yes	No
1.	①	KR1997-66681	10/13/1997	Korea	—		X
2.							

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)		
Ref. Desig.	Examiner's Initials	
1.	—	Communication from Korean Patent Office regarding counterpart application.

* One or more of the English translation documents submitted herewith may be Abstracts only or partial machine created translations from the Japanese Patent Office. As such, the submitter does not necessarily vouch for their accuracy. Additional information may be obtained from the Japanese Patent Office web site at www.ipa.go.jp.

Examiner: <i>[Signature]</i>	Date Considered: 4/1/04
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EXAMINER: Please initial if citation considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



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**PATENT AND TRADEMARK OFFICE
INFORMATION DISCLOSURE CITATION**
(Use several sheets if necessary)

Sheet 1 of 1

ATTORNEY DOCKET No.	SERIAL No.
9319S-000289	10/001,249
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FILING DATE	GROUP
October 31, 2001	2871

FOREIGN PATENT DOCUMENTS

R f. D sig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation *	
						Yes	No
1.	D	11-352505	12/24/1999	Japan		X	
2.	D	02-208634	08/20/1990	Japan		X	

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)

R f. D sig.	Examiner's Initials	
1.		Examination report issued June 24, 2003 for corresponding Japanese Application No. 2001-253470.

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Examiner: <i>James C. Dull</i>	Date Considered: 4/1/04
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EXAMINER: Please initial if citation considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.